

IAPY Rec'd PCT/PTO 27 JUN



ATTORNEY DOCKET NO. 0075/021001

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Detlef KNEBEL et al.

Art Unit: 2878

Application No.: 10/521,563

Examiner:

Title: METHOD FOR LOCALLY HIGHLY RESOLVED, MASS-SPECTROSCOPIC

CHARACTERIZATION OF SURFACES USING SCANNING PROBE

TECHNOLOGY

International Application No.: PCT/DE2003/002493

International Filing Date : July 24, 2003

Priority Date

: July 24, 2002

U.S. Filing Date

: January 19, 2005

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

REQUEST FOR CORRECTION OF INVENTORSHIP UNDER 37 CFR 1.48(a)

Sir:

Applicants respectfully request that Mr. Klaus DREISEWERD be added as an inventor in this application under 37 CFR 1.48(a). Accompanying this request for correction of inventorship is applicants' new Declaration under 37 CFR 1.63, a statement from each inventor that this error was without deceptive intent and the written consent of the assignee for this inventorship change.

The payment (the \$130.00 fee set forth in 37 C.F.R. 1.17(i) for processing fee for taking action under 37 CFR 1.48(a)) is currently due. The Commissioner is hereby authorized to charge this \$130.00 fee as well as any other fee that may be required to keep this application in force to the Credit Card number listed on the attached Credit Card Payment Form (PTO-2038 Form),

Request for Correction of Inventorship under 37 CFR 1.48(a) Application No.: 10/521,563

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referencing Attorney Docket No. 0075/021001. A duplicate copy of this paper is enclosed.

Applicants submit that all of the requirements for correction of inventorship have been met and therefore, applicants respectfully request that this request for correction of inventorship be granted.

If there are any questions or concerns regarding this matter, the Examiner is requested to telephone the undersigned at the telephone number listed below.

Respectfully submitted,

Date: June 27, 2006

Randolph A. Smith Reg. No. 32,548

SMITH PATENT OFFICE

1901 Pennsylvania Ave., N.W.

Suite 901

Washington, DC 20006-3433 Telephone: 202/530-5900 Facsimile: 202/530-5902

Knebel062706



COMBINED DECLARATION AND POWER OF ATTORNEY

As a below named inventor, I hereby declare that:

My residence, post office address and citizenship are as stated below next to my name,

I believe I am the original, first and sole inventor (if only one name is listed below) or an original, first and joint inventor (if plural names are listed below) of the subject matter which is claimed and for which a patent is sought on the invention entitled <u>METHOD FOR LOCALLY HIGHLY RESOLVED</u>, MASS-SPECTROSCOPIC CHARACTERIZATION OF SURFACES USING SCANNING PROBE TECHNOLOGY, the specification of which

is attached hereto.				
X was filed or	1 <u>January 19, 20</u>	005 as Application Seri	al No. <u>10/521,563</u>	
and was amer				
		PCT International App		
filed on	and as	amended under PCT A	rticle 19 on	
		ed and understand the c		entified
specification, including th	e ciaims, as am	ended by any amendme	nt referred to above.	
I acknowledge th accordance with Title 37,		se all information I knows Regulations, Section		entability in
I hereby claim fo application(s) for patent o designated at least one con identified below, by check PCT international applica- claimed.	r inventor's cer untry other than cing below, any	the United States of Air foreign application for	y PCT international appendica, listed below an patent or inventor's cer	plication which d have also rtificate, or of any
102 34 507.4	Germany	July 24, 2002	x	
PCT/DE2003/002493	WIPO	July 24, 2003	X	

(Application Number)	(Country)	(Filing Date)	(Priority Claimed)	(Priority Not Claimed)

I hereby appoint the following attorneys and/or agents to prosecute this application and to transact all business in the Patent and Trademark Office connected therewith: Randolph A. Smith, Reg. No. 32,548.

Address all telephone calls to Randolph A. Smith at telephone number 202-530-5900.

Address all correspondence to <u>Randolph A. Smith</u>, Smith Patent Office, 1901 Pennsylvania Ave., N.W., Suite 901, Washington, D.C. 20006-3433 (Fax: 202-530-5902)

I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code and that each willful false statements may jeopardize the validity of the application or any patents issued thereon.



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WRITTEN CONSENT OF ASSIGNEE FOR CORRECTION OF INVENTORSHIP

Sir:

I, Toosky 1-44kc , am the authorized representative of JPK Instruments AG, the Assignee of this application. Instruments AG consents to the change of inventorship in this application.

Respectfully submitted,

Date: /6/05/06

Title:

JPK Instruments AG Bouchéstrasse 12

ASSIGNMENT

For good and valuable consideration, the receipt and sufficiency of which are hereby acknowledged, the undersigned hereby assign(s), transfer(s) and set(s) over to:

JPK Instruments AG

having the address:

Bouchéstrasse 12 12435 Berlin Germany

(hereinafter designated as the "ASSIGNEE"), its successors and assigns, the entire right, title, and interest for the United States in the invention, and all applications for patent and any Letters Patent which may be granted therefor, including said application, and all United States Letters Patents which may be granted therefore, and all divisions, reissues, continuations and extensions thereof, the said interest being the entire ownership of said Letters Patent when granted to be held by said ASSIGNEE, its successors, assigns or their legal representatives, to the full end of the term for which said Letters Patent may be granted, as fully and entirely as the same would have been and enjoyed by Assignor(s) if this assignment had not been made, the application being known by the Title:

METHOD FOR LOCALLY HIGHLY RESOLVED, MASS-SPECTROSCOPIC CHARACTERIZATION OF SURFACES USING SCANNING PROBE TECHNOLOGY

Attorney Docket No. 0075/021001

for which the undersigned has/have executed an application for patent in the United States of America on the same day herewith. Where this instrument is not filed concurrently with the application, the following identifying information may be added after execution:

Application No. 10/521,563 Filing Date: January 19, 2005

1. The undersigned hereby agree(s) to sign and execute any further documents and instruments which may be necessary, lawful and proper in the prosecution of said above-named application or in the preparation and prosecution of any continuing, continuation-in-part, substitute, divisional, renewal, reviewed or reissue application or in any amendments, extension of interference proceedings, or otherwise to secure the title thereto to the ASSIGNEE.

- 2. The undersigned agree(s) to execute all papers and documents and perform any act that may be necessary in connection with claims or provisions of the International Convention for Protection of Industrial Property or similar agreements.
- 3. The undersigned agree(s) to perform all affirmative acts that may be necessary to obtain a grant of a valid United States palent to the ASSIGNEE.
- 4. The undersigned hereby authorize(s) and request(s) the Commissioner of Patents and Trademarks in the United States to issue any and all Letters Patents resulting from said application or any division or divisions or continuing applications thereof to the said ASSIGNEE.
- 5. The undersigned hereby grant(s) to Randolph A. Smith and Smith Patent Office the power to insert on this assignment any further identification which may be necessary or desirable in order to comply with the rules of the United States Patent and Trademark Office for recordation of this document.

In witness whereof, executed by the undersigned on the date(s) opposite the undersigned name(s).

June 15/2006

Date

Typed Name: Detlef KNEBEL

Typed Name: Matthias AMREINS

June 12/2006

Date

Typed Name: Matthias AMREINS

Typed Name: Typed Name:

This assignment may be signed before a U.S. Notary Public or before at least the research who also sign here:

June 15/2006

Typed Name:

June 15/2006

MAROOLO

Typed Name:



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STATEMENT FROM INVENTOR REGARDING INVENTORSHIP ERROR

Sir:

I, Detlef KNEBEL, am an inventor of the invention in this application. I hereby state that the inventorship error occurred without deceptive intention.

Respectfully submitted,

Date: June 15/2006

Detlef KNEBEL

JPK Instruments AG Bouchéstrasse 12

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Detlef KNEBEL et al.

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une US, UB

STATEMENT FROM INVENTOR REGARDING INVENTORSHIP ERROR

Sir:

I, Matthias AMREIN, am an inventor of the invention in this application. I hereby state that the inventorship error occurred without deceptive intention.

Respectfully submitted,

Matthias AMREIN

JPK Instruments AG

Bouchéstrasse 12



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STATEMENT FROM INVENTOR REGARDING INVENTORSHIP ERROR

Sir:

I, Klaus DREISEWERD, am an inventor of the invention in this application. I hereby state that the inventorship error occurred without deceptive intention.

Respectfully submitted,

Date: June 12/2006

Klaus DREISEWERD

✓ JPK Instruments AG Bouchéstrasse 12